

# WM3HA160065E

## N-Channel SiC Power MOSFET

### G3 MOSFET Technology

|                   |   |     |    |
|-------------------|---|-----|----|
| $V_{DS}$          | = | 650 | V  |
| $R_{DS(on)}$      | = | 160 | mΩ |
| $I_D@25^{\circ}C$ | = | 20  | A  |

#### Features

- High Blocking Voltage with Low On-Resistance
- High Speed Switching with Low Capacitance
- Easy to Parallel and Simple to Drive
- 15V / 0V  $V_{GS}$  compatible with most flyback controllers

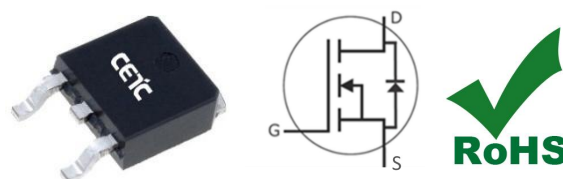
#### Benefits

- Higher System Efficiency
- Reduced Cooling Requirements
- Increased Power Density
- Increased System Switching Frequency
- Reduction of heat sink requirements

#### Applications

- Solar and UPS inverters
- On Board Charger
- High voltage DC/DC converters
- Switched mode power supplies
- Load switch
- LED/LCD/PDP TV and monitor Lighting

#### Package



| Part Number  | Package   | Marking      |
|--------------|-----------|--------------|
| WM3HA160065E | TO-252-2L | WM3HA160065E |

#### Maximum Ratings ( $T_c=25^{\circ}C$ unless otherwise specified)

| Symbol         | Parameter                                   | Value            | Unit        | Test Conditions                         | Note    |
|----------------|---------------------------------------------|------------------|-------------|-----------------------------------------|---------|
| $V_{DSmax}$    | Drain-Source Voltage                        | 650              | V           | $V_{GS}=0V, I_D=100\mu A$               |         |
| $V_{GSmax}$    | Gate-Source Voltage                         | -10/+23          | V           | Absolute maximum values                 |         |
| $V_{GSop}$     | Gate-Source Voltage                         | -5...0/+15...+18 | V           | Recommended operational values          |         |
| $I_D$          | Continuous Drain Current                    | 20               | A           | $V_{GS}=15V, T_c=25^{\circ}C$           | Fig. 19 |
|                |                                             | 14               |             | $V_{GS}=15V, T_c=100^{\circ}C$          |         |
|                |                                             | 21               |             | $V_{GS}=18V, T_c=25^{\circ}C$           |         |
|                |                                             | 15               |             | $V_{GS}=18V, T_c=100^{\circ}C$          |         |
| $I_{D(pulse)}$ | Pulsed Drain Current                        | 50               | A           | Pulse width $t_p$ limited by $T_{Jmax}$ |         |
| $P_D$          | Power Dissipation                           | 95               | W           | $T_c=25^{\circ}C, T_J=175^{\circ}C$     | Fig. 20 |
| $T_J, T_{STG}$ | Operating Junction and Storage Temperature  | -55 to +175      | $^{\circ}C$ |                                         |         |
| $T_L$          | Solder Temperature, 1.6mm from case for 10s | 260              | $^{\circ}C$ |                                         |         |

**Electrical Characteristics** ( $T_C=25^{\circ}\text{C}$  unless otherwise specified)

| Symbol        | Parameter                        | Min. | Typ. | Max. | Unit       | Test Conditions                                                              | Note       |
|---------------|----------------------------------|------|------|------|------------|------------------------------------------------------------------------------|------------|
| $V_{(BR)DSS}$ | Drain-Source Breakdown Voltage   | 650  | /    | /    | V          | $V_{GS}=0V, I_D=100\mu A$                                                    |            |
| $V_{GS(th)}$  | Gate Threshold Voltage           | 2.4  | 3.2  | 4.0  | V          | $V_{DS}=V_{GS}, I_D=2mA$                                                     | Fig. 11    |
|               |                                  | /    | 2.4  | /    |            | $V_{DS}=V_{GS}, I_D=2mA, T_J=175^{\circ}\text{C}$                            |            |
| $I_{DSS}$     | Zero Gate Voltage Drain Current  | /    | 1    | 10   | $\mu A$    | $V_{DS}=650V, V_{GS}=0V$                                                     |            |
| $I_{GSS+}$    | Gate-Source Leakage Current      | /    | 10   | 50   | nA         | $V_{DS}=0V, V_{GS}=23V$                                                      |            |
| $I_{GSS-}$    | Gate-Source Leakage Current      | /    | 10   | 50   | nA         | $V_{DS}=0V, V_{GS}=-10V$                                                     |            |
| $R_{DS(on)}$  | Drain-Source On-State Resistance | /    | 160  | 220  | m $\Omega$ | $V_{GS}=15V, I_D=7A$                                                         | Fig. 4,5,6 |
|               |                                  | /    | 210  | /    | m $\Omega$ | $V_{GS}=15V, I_D=7A, T_J=175^{\circ}\text{C}$                                |            |
|               |                                  | /    | 130  | 180  | m $\Omega$ | $V_{GS}=18V, I_D=7A$                                                         |            |
|               |                                  | /    | 173  | /    | m $\Omega$ | $V_{GS}=18V, I_D=7A, T_J=175^{\circ}\text{C}$                                |            |
| $g_{fs}$      | Transconductance                 | /    | 6.2  | /    | S          | $V_{DS}=20V, I_{DS}=7A$                                                      | Fig. 7     |
|               |                                  | /    | 5.6  | /    |            | $V_{DS}=20V, I_{DS}=7A, T_J=175^{\circ}\text{C}$                             |            |
| $C_{iss}$     | Input Capacitance                | /    | 448  | /    | pF         | $V_{GS}=0V$                                                                  | Fig. 17,18 |
| $C_{oss}$     | Output Capacitance               | /    | 44   | /    |            | $V_{DS}=400V$                                                                |            |
| $C_{rss}$     | Reverse Transfer Capacitance     | /    | 2.2  | /    |            | $f=1MHz$                                                                     |            |
| $E_{oss}$     | $C_{oss}$ Stored Energy          | /    | 2.8  | /    | $\mu J$    | $V_{AC}=25mV$                                                                | Fig. 16    |
| $E_{ON}$      | Turn-On Switching Energy         | /    | 24   | /    | $\mu J$    | $V_{DS}=400V, V_{GS}=0V/15V$                                                 |            |
| $E_{OFF}$     | Turn-Off Switching Energy        | /    | 16   | /    |            | $I_D=7A, R_{G(ext)}=2.5\Omega, L=100\mu H$                                   |            |
| $t_{d(on)}$   | Turn-On Delay Time               | /    | 11   | /    | ns         | $V_{DS}=400V, V_{GS}=0V/15V, I_D=7A$<br>$R_{G(ext)}=2.5\Omega, R_L=80\Omega$ |            |
| $t_r$         | Rise Time                        | /    | 8.6  | /    |            |                                                                              |            |
| $t_{d(off)}$  | Turn-Off Delay Time              | /    | 18.2 | /    |            |                                                                              |            |
| $t_f$         | Fall Time                        | /    | 14.6 | /    |            |                                                                              |            |
| $R_{G(int)}$  | Internal Gate Resistance         | /    | 7    | /    | $\Omega$   | $f=1MHz, V_{AC}=25mV$                                                        |            |
| $Q_{GS}$      | Gate to Source Charge            | /    | 4.6  | /    | nC         | $V_{DS}=400V$                                                                | Fig. 12    |
| $Q_{GD}$      | Gate to Drain Charge             | /    | 3.8  | /    |            | $V_{GS}=0V/15V$                                                              |            |
| $Q_G$         | Total Gate Charge                | /    | 12.6 | /    |            | $I_D=7A$                                                                     |            |

**Reverse Diode Characteristics**

| Symbol    | Parameter                        | Typ. | Max. | Unit | Test Conditions                                    | Note        |
|-----------|----------------------------------|------|------|------|----------------------------------------------------|-------------|
| $V_{SD}$  | Diode Forward Voltage            | 4.2  | /    | V    | $V_{GS}=-5V, I_{SD}=3.5A, T_J=25^{\circ}\text{C}$  | Fig. 8,9,10 |
|           |                                  | 3.6  | /    |      | $V_{GS}=-5V, I_{SD}=3.5A, T_J=175^{\circ}\text{C}$ |             |
| $I_S$     | Continuous Diode Forward Current | /    | 16   | A    | $T_C=25^{\circ}\text{C}$                           |             |
| $t_{rr}$  | Reverse Recover Time             | 12   | /    | ns   | $V_R=400V, I_{SD}=3.5A$                            |             |
| $Q_{rr}$  | Reverse Recovery Charge          | 28   | /    | nC   |                                                    |             |
| $I_{rrm}$ | Peak Reverse Recovery Current    | 1.8  | /    | A    |                                                    |             |

### Thermal Characteristics

| Symbol          | Parameter                                   | Typ. | Max. | Unit                        | Test Conditions | Note |
|-----------------|---------------------------------------------|------|------|-----------------------------|-----------------|------|
| $R_{\theta JC}$ | Thermal Resistance from Junction to Case    | 1.58 | /    | $^{\circ}\text{C}/\text{W}$ |                 |      |
| $R_{\theta JA}$ | Thermal Resistance from Junction to Ambient | /    | 40   |                             |                 |      |

## Typical Performance

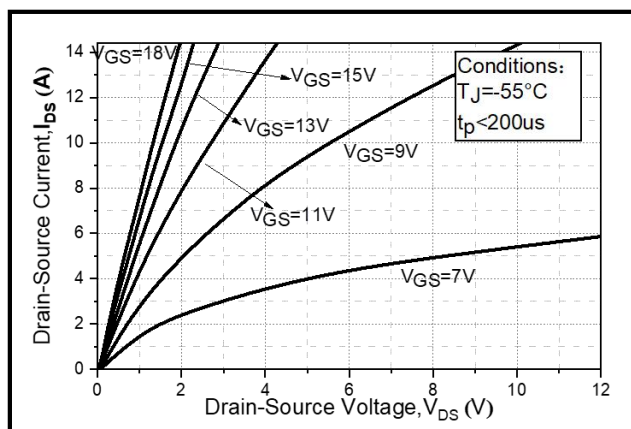


Figure 1. Output Characteristics  $T_J = -55^{\circ}\text{C}$

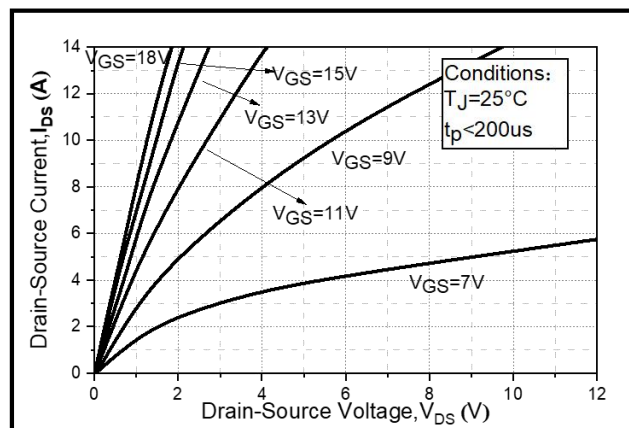


Figure 2. Output Characteristics  $T_J = 25^{\circ}\text{C}$

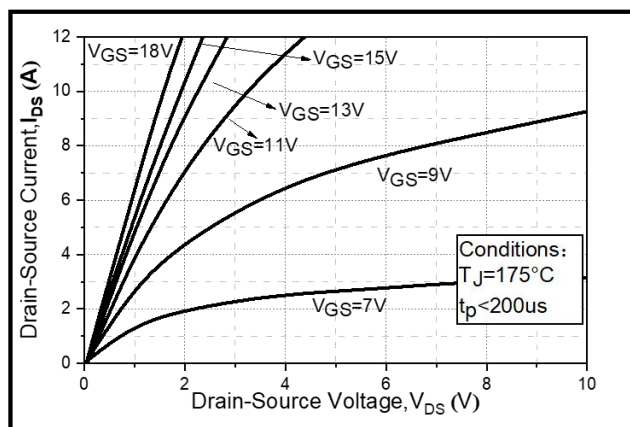


Figure 3. Output Characteristics  $T_J = 175^{\circ}\text{C}$

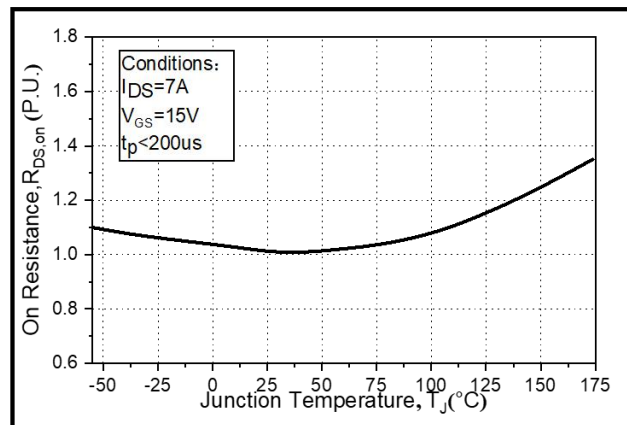


Figure 4. Normalized On-Resistance vs. Temperature

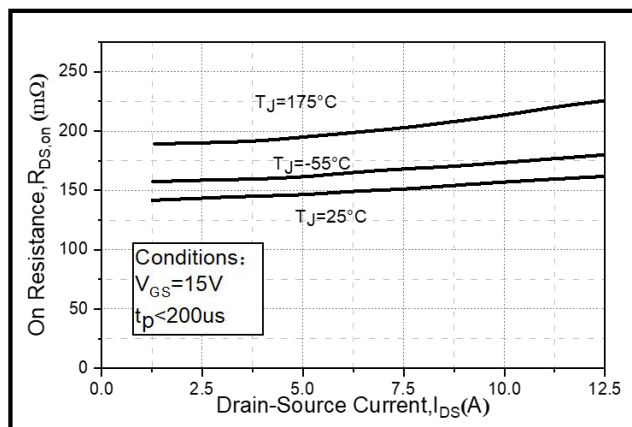


Figure 5. On-Resistance vs. Drain Current For Various Temperatures

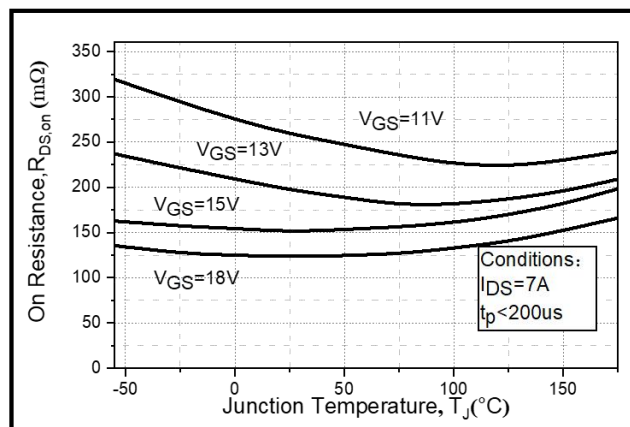


Figure 6. On-Resistance vs. Temperature For Various Gate Voltage

## Typical Performance

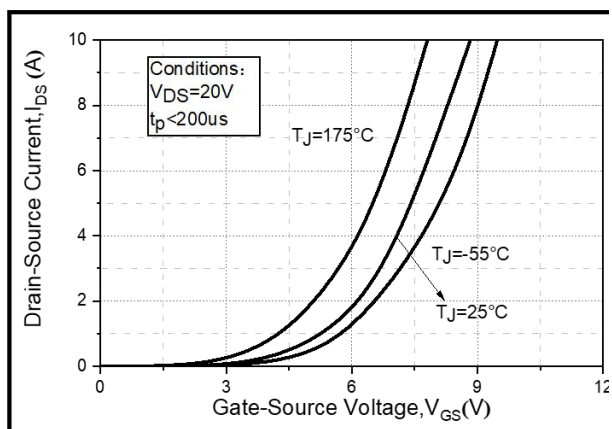


Figure 7. Transfer Characteristic for Various Junction Temperatures

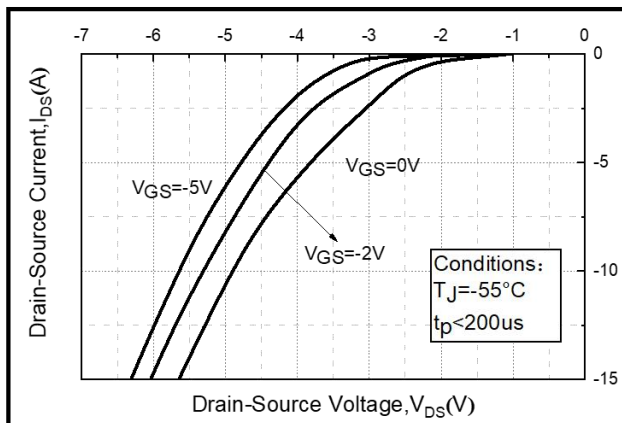


Figure 8. Body Diode Characteristic at -55°C

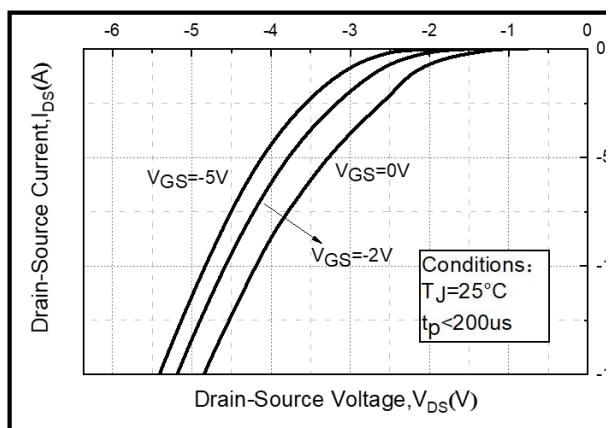


Figure 9. Body Diode Characteristic at 25°C

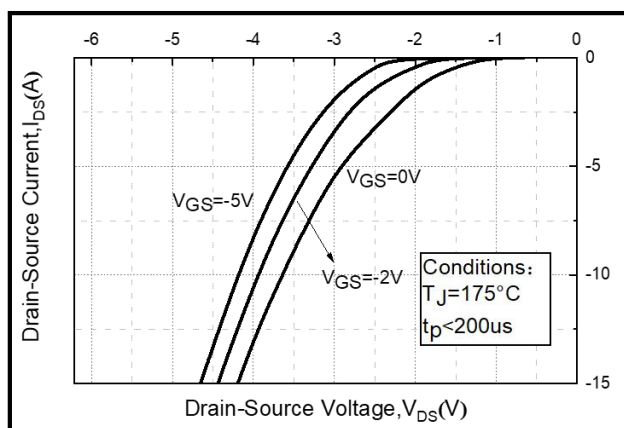


Figure 10. Body Diode Characteristic at 175°C

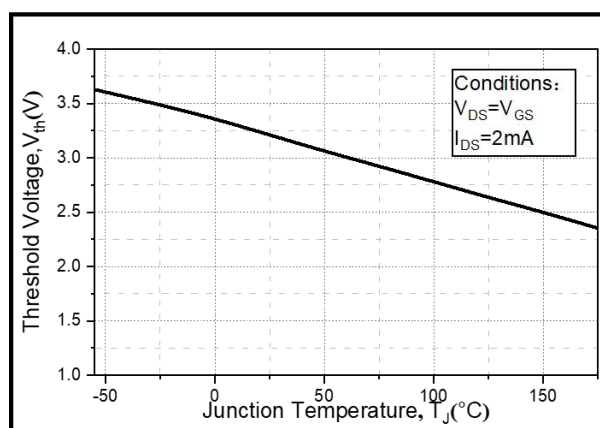


Figure 11. Threshold Voltage vs. Temperature

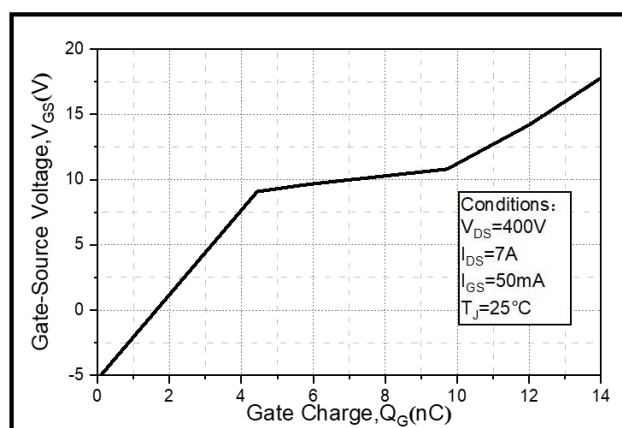


Figure 12. Gate Charge Characteristics

## Typical Performance

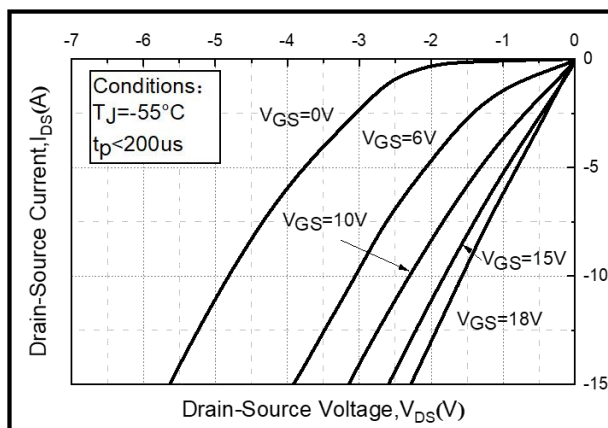


Figure 13. 3rd Quadrant Characteristic at

-55°C

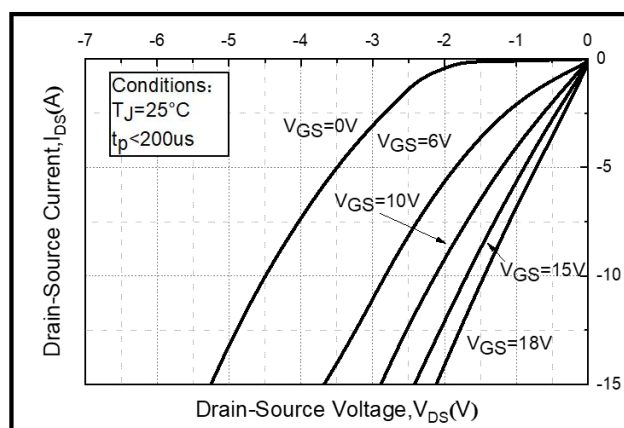


Figure 14. 3rd Quadrant Characteristic at 25°C

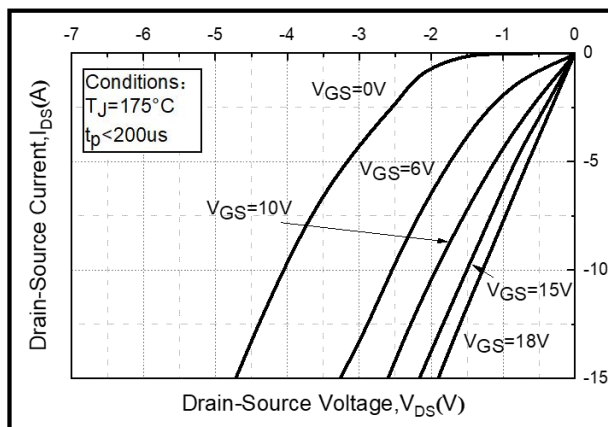


Figure 15. 3rd Quadrant Characteristic at 175°C

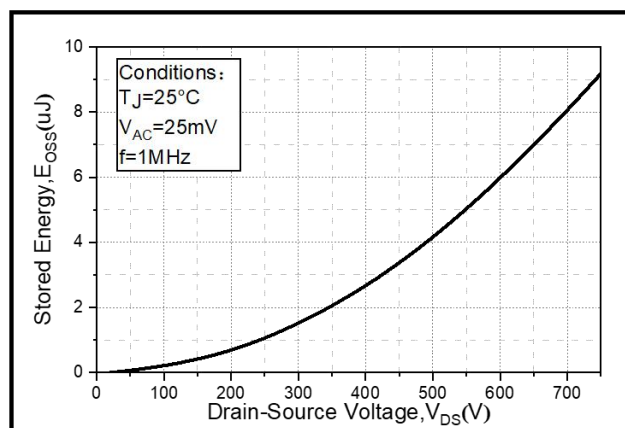


Figure 16. Output Capacitor Stored Energy

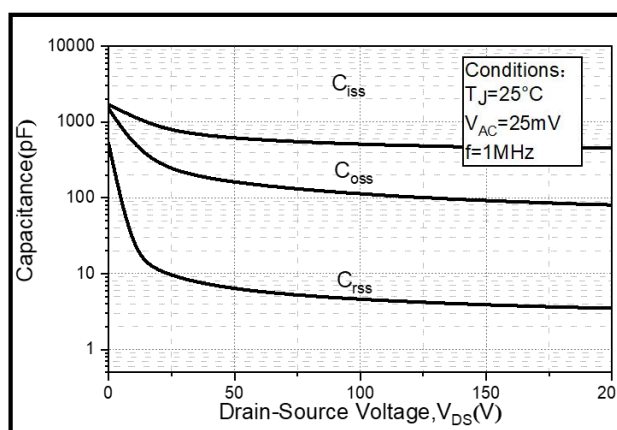


Figure 17. Capacitances vs. Drain-Source Voltage  
(0 - 200V)

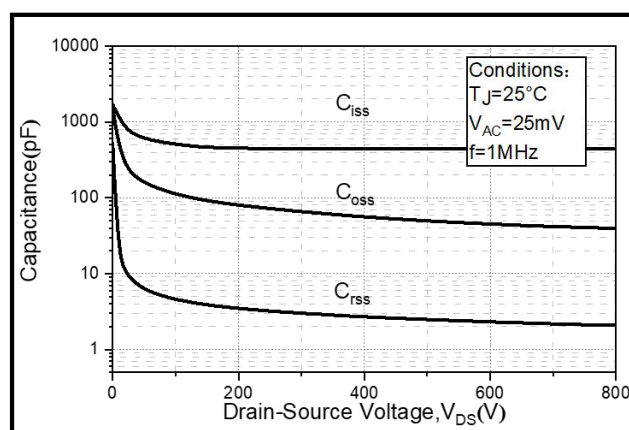


Figure 18. Capacitances vs. Drain-Source Voltage  
(0 - 800V)

## Typical Performance

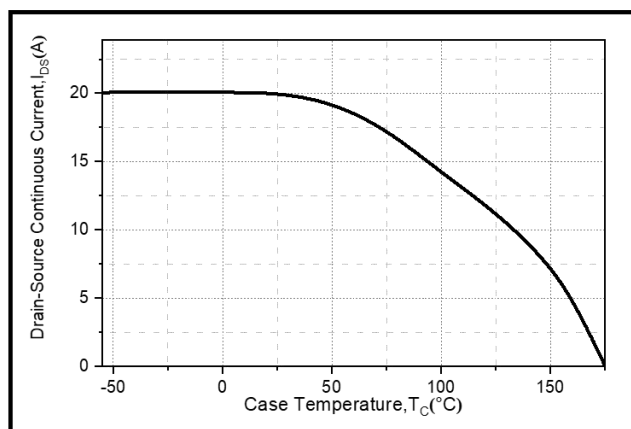


Figure 19. Continuous Drain Current vs.  
Case Temperature

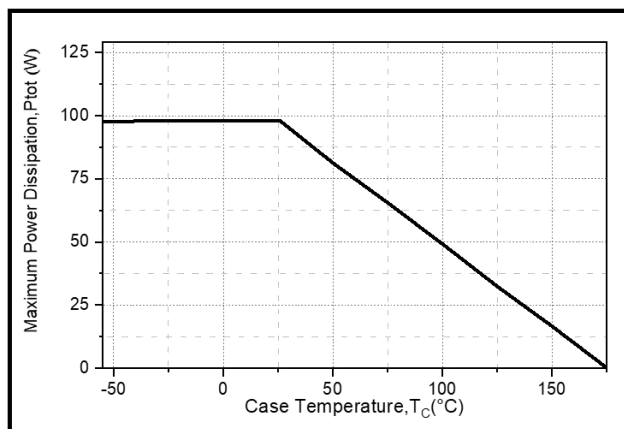
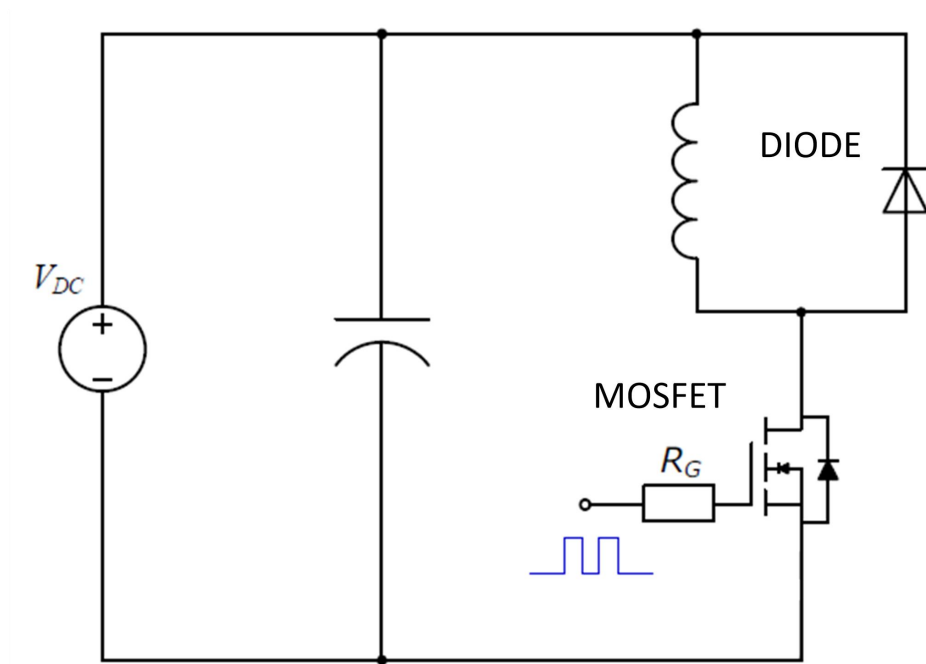


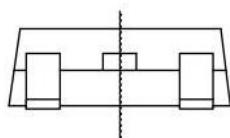
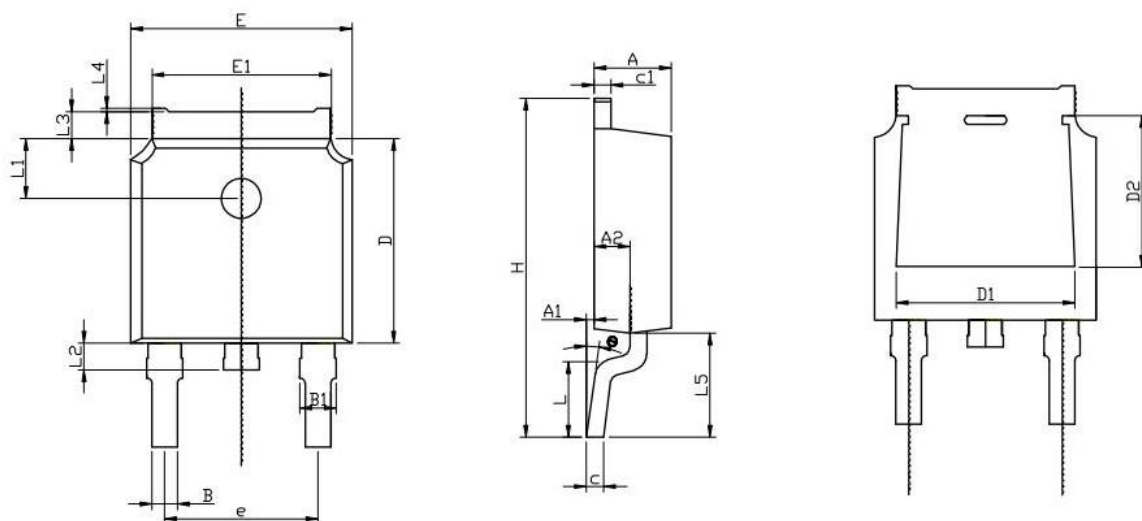
Figure 20. Maximum Power Dissipation vs.  
Case Temperature

**Test Circuit Schematic**

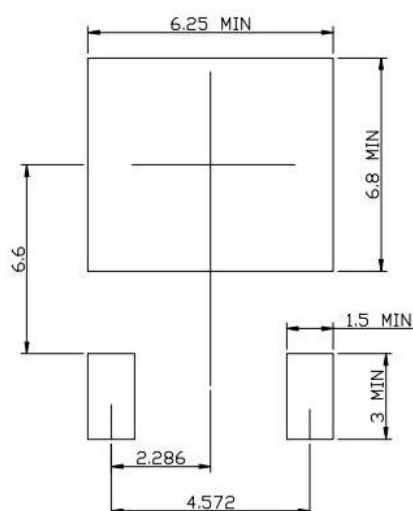


**Figure 21. Clamped Inductive Switching  
Waveform Test Circuit**

## Package Dimensions



### RECOMMENDED LAND PATTERN



|    | MIN  | NOM      | MAX   |
|----|------|----------|-------|
| A  | 2.15 | 2.30     | 2.45  |
| A1 | 0.05 | 0.10     | 0.20  |
| A2 | 0.91 | 1.07     | 1.22  |
| B  | 0.66 | 0.76     | 0.86  |
| B1 | 0.93 | 1.08     | 1.23  |
| C  | 0.40 | 0.50     | 0.60  |
| C1 | 0.40 | 0.50     | 0.60  |
| D  | 5.95 | 6.10     | 6.25  |
| D1 | —    | 4.8REF   | —     |
| D2 | —    | 3.8REF   | —     |
| E  | 6.45 | 6.60     | 6.75  |
| E1 | 5.12 | 5.32     | 5.52  |
| L  |      | 1.65     |       |
| L1 | 1.58 | 1.78     | 1.98  |
| L2 | 0.60 | 0.80     | 1.00  |
| L3 | 0.70 | 0.85     | 1.00  |
| L4 | 0.00 | 0.05     | 0.20  |
| L5 | 2.80 | 3.10     | 3.40  |
| H  | 9.80 | 10.10    | 10.40 |
| Θ  | 0°   |          | 8°    |
| e  |      | 4.572REF |       |

UNIT: mm



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